Notice of References Cited Application/Control No. 10/725,760 Examiner Sylvia R. MacArthur Applicant(s)/Patent Under Reexamination HUR ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,902,682	06-2005	Shang et al.	216/67
	В	US-6,887,317	05-2005	Or et al.	118/728
	С	US-6,773,562	08-2004	Inagawa et al.	204/298.15
	D	US-6,676,761	01-2004	Shang et al.	118/728
	Е	US-6,596,086	07-2003	Honma et al.	118/728
	F	US-6,544,340	04-2003	Yudovsky, Joseph	118/728
	G	US-6,435,798	08-2002	Satoh, Kiyoshi	414/217
	Н	US-2005/0194100	09-2005	Or et al.	156/345.51
	1	US-2005/0155557	07-2005	Hwang et al.	118/728
	J	US-2004/0089239	05-2004	Shang et al.	118/729
	к	US-2003/0079691	05-2003	Shang et al.	118/729
	L	US-2003/0029569	02-2003	Natsuhara et al.	156/345.51
	М	US-2002/0174950	11-2002	Park, Sang-Gee	156/345.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	ø					
	R					
	s					
	Т					·

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧	·					
	w						
	×						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.